

华润微电子(重庆)有限公司

Features

- Uses CRM(CQ) advanced SkyMOS2 technology
- Extremely low on-resistance R_{DS(on)}
- Excellent QqxRDS(on) product(FOM)
- Qualified according to JEDEC criteria

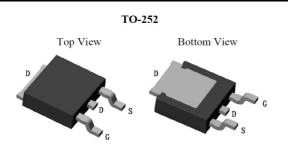
Applications

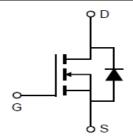
- Synchronous Rectification for AC/DC Quick Charger
- Battery management
- UPS (Uninterrupible Power Supplies)

Product Summary

V_{DS}	100V
R _{DS(on)@10V typ}	11.0mΩ
R _{DS(on)@4.5V typ}	14.3mΩ
I_{D}	65A

100% Avalanche Tested





Package Marking and Ordering Information

Part #	Marking	Package	Packing	Reel Size	Tape Width	Qty
CRSD130N10L2	CRSD130N10L2	TO-252	Tape\Reel	N/A	N/A	2500pcs

Absolute Maximum Ratings

Parameter	Symbol	Value	Unit
Drain-source voltage	V_{DS}	100	V
Continuous drain current			
T _C = 25°C (Silicon limit)	I_{D}	65	Α
T _C = 100°C (Silicon limit)		41	
Pulsed drain current ($T_A = 25$ °C, t_p limited by T_{jmax})	${ m I}_{ m D\ pulse}$	261	Α
Avalanche Current (L=0.5mH)	I_{AS}	16	Α
Avalanche energy, single pulse (L=0.5mH, Rg=25 Ω)	E _{AS}	64	mJ
Repeative avalanche Current (L=0.5mH)*	I_{AR}	12	Α
Repeative avalanche (L=0.5mH)*	E _{AR}	33	mJ
Gate-Source voltage	V_{GS}	±20	V
Power dissipation ($T_C = 25^{\circ}C$, $R_{thJA}=94$ K/W)	P _{tot}	101.2	W
Operating junction and storage temperature	T_j , T_{stg}	-55+150	°C

^{*}Repetitive rating, pulse width limited by junction temperature TJ(MAX)=150°C. Ratings are based on low frequency and duty cycles to keep initial TJ =25°C.





Thermal Resistance

Parameter	Symbol	Max	Unit
Thermal resistance, junction – case.	R_{thJC}	1.24	°C/W
Thermal resistance, junction – ambient(min. footprint)*	R_{thJA}	94	1 °C/ W
Soldering temperature, wave and reflow soldering are allowed (reflow MSL1)	T_{sold}	260	°C

^{*} Surface mounted FR-4 board by JEDEC (jesd51-7). Continuous current at TC=25 $^{\circ}$ C is silicon limited

Electrical Characteristic (at Tj = 25 °C, unless otherwise specified)

Parameter	Symbol	Value			Unit	Test Condition	
- rai ailletei	min. typ. max.		Oiiit	lest Condition			
Static Characteristic							
Drain-source breakdown voltage	BV _{DSS}	100	115	-	V	V _{GS} =0V, I _D =250uA	
Gate threshold voltage	V _{GS(th)}	1.4	1.8	2.2	V	$V_{DS}=V_{GS}$, $I_{D}=250$ uA	
Zero gate voltage drain current	I _{DSS}	-	0.05	1	μΑ	$V_{DS} = 100V, V_{GS} = 0V$ $T_{j} = 25^{\circ}C$	
		-	-	10		T _j =125°C	
Gate-source leakage current	I_{GSS}	-	10	100	nA	V_{GS} =±20V, V_{DS} =0V	
		-	11.0	13.2		V_{GS} =10V, I_D =50A	
Drain-source on-state resistance	D	-	16.7	20.0		T _j =100°C	
	R _{DS(on)}	-	14.3	17.2	mΩ	V _{GS} =4.5V, I _D =50A	
		-	20.1	24.1		T _j =100°C	
Transconductance	g _{fs}	-	70.8	-	S	$V_{DS}=5V,I_{D}=50A$	

Dynamic Characteristic

Input Capacitance	C _{iss}	809	1618	2427		
Output Capacitance	C _{oss}	139	277	416	pF	V_{GS} =0V, V_{DS} =50V, f =1MHz
Reverse Transfer Capacitance	C _{rss}	11	22	44	į.	
Gate Total Charge	Q_{G}	ı	28	42		10// // 50//
Gate-Source charge	Q_{gs}	ı	7	10	nC	V_{GS} =10V, V_{DS} =50V, I_{D} =50A, f=1MHz
Gate-Drain charge	Q_{gd}	ı	5	7		
Turn-on delay time	t _{d(on)}	ı	30	45		$V_{GS}=10V$, $V_{DD}=50V$, $R_{G_ext}=2.7\Omega$
Rise time	t _r	ı	81	122	nc	
Turn-off delay time	t _{d(off)}	ı	24	36	ns	
Fall time	t _f	-	7	11		
Gate resistance	R_{G}	0.8	1.6	2.4	Ω	V _{GS} =V _{DS} =0V, f=1MHz





Body Diode Characteristic

Parameter	Symbol	Value			Unit	Took Condition
	Syllibol	min.	typ.	max.	Unit	Test Condition
Body Diode Forward Voltage	V_{SD}	-	0.87	1	V	V _{GS} =0V,I _{SD} =20A
Body Diode Reverse Recovery Time	t _{rr}	-	80	-	ns	I _F =50A, dI/dt=100A/μs
Body Diode Reverse Recovery Charge	Q _{rr}	-	198	-	nC	





Typical Performance Characteristics

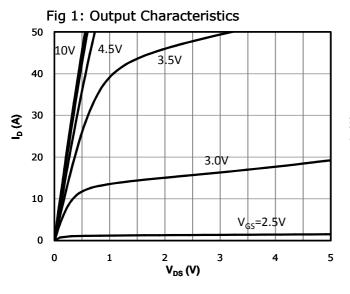
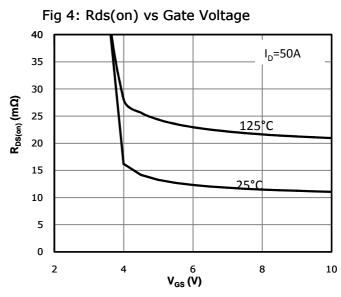


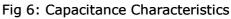
Fig 2: Transfer Characteristics 50 $V_{DS}=5V$ 40 30 ا_ه 125°C 20 25°C 10 0 0 5 1 3 4 V_{GS} (V)

Fig 3: Rds(on) vs Drain Current and Gate Voltage 16.0 V_{GS}=4.5V 14.0 12.0 $V_{GS}=10V$ 10.0 8.0 6.0 15 25 35 45 I_D (A) Fig 5: Rds(on) vs. Temperature



2.2 2.1 2.0 1.9 $V_{GS}=10V$ R_{DS(on)}_Normalized 1.8 I_D=50A 1.7 1.6 1.5 $V_{GS}=4.5V$ 1.4 $I_D = 50A$ 1.3 1.2 1.1 1.0 0.9 0.8 0.7 75 25 50 100 125 150

Tj - Junction Temperature (°C)



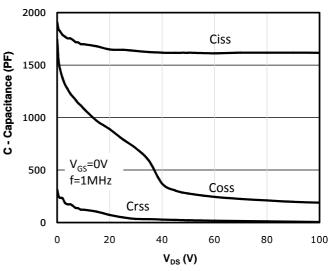




Fig 7: Gate Charge Characteristics

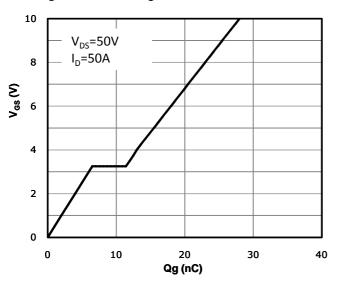


Fig 8: Body-diode Forward Characteristics

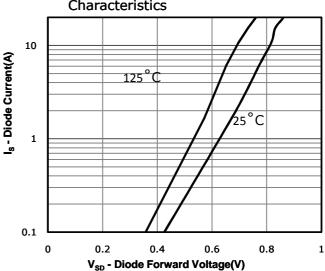


Fig 9: Power Dissipation

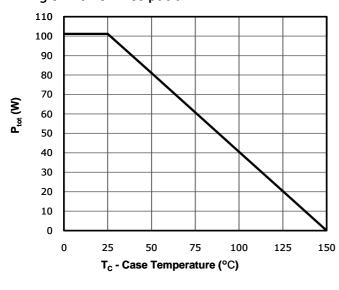


Fig 10: Drain Current Derating

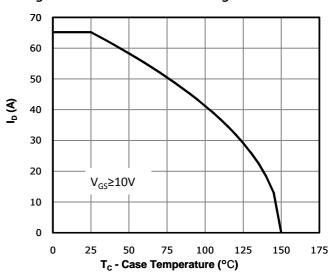


Fig 11: Safe Operating Area

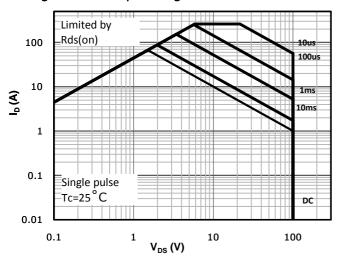
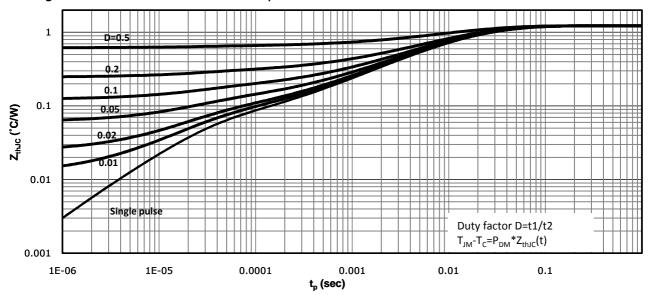




Fig 12: Max. Transient Thermal Impedance

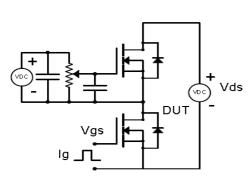


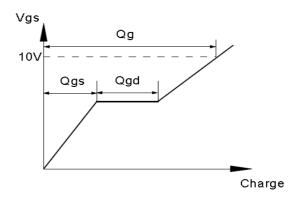




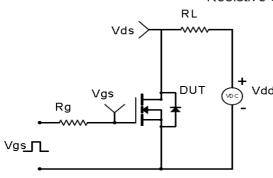
Test Circuit & Waveform

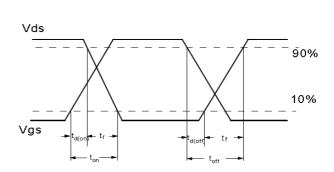
Gate Charge Test Circuit & Waveform



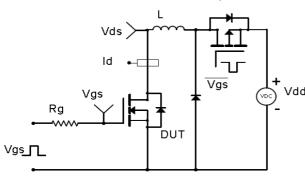


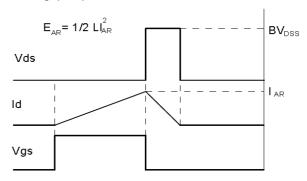
Resistive Switching Test Circuit & Waveforms



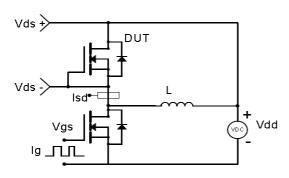


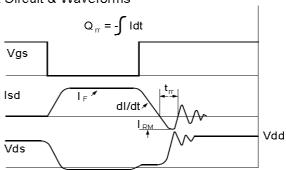
Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

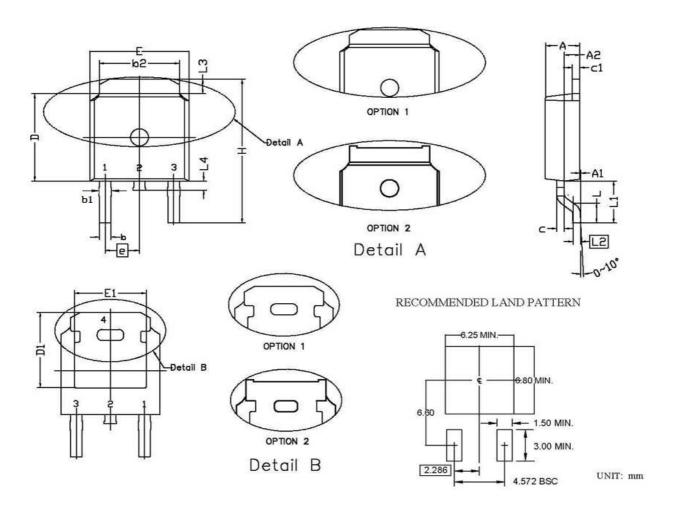








Package Outline: TO-252-3L



Symbol	Dimensions 1	In Millimeters	Dimension	s In Inches
Symbol	Min.	Max.	Min.	Max.
Α	2.15	2.45	0.085	0.096
A1	0.00	0.15	0.000	0.006
A2	0.76	1.36	0.030	0.054
b	0.60	0.91	0.024	0.036
b1	0.65	1.15	0.026	0.045
b2	5.00	5.64	0.197	0.222
С	0.45	0.61	0.018	0.024
c1	0.36	0.66	0.014	0.026
D	5.80	6.30	0.228	0.248
D1	5.00	6.00	0.197	0.236
е	2.29 BSC.		0.090	D BSC.
E	6.30	6.90	0.248	0.272
E1	4.55	5.30	0.179	0.209
Н	9.40	10.48	0.370	0.413
L	1.18	1.70	0.046	0.067
L1	2.92 REF		0.11	5 REF
L2	0.36	0.66	0.014	0.026
L3	0.72	1.35	0.028	0.053
L4	0.60	1.20	0.024	0.047



SkyMOS2 N-MOSFET 100V, $11.0m\Omega$, 65A



Revision History

Revison	Date	Major changes
1.0	2018-06-12	priliminary version.
2.0	2019-05-28	Supplement package outline info.

Disclaimer

Unless otherwise specified in the datasheet, the product is designed and qulified as a standard commercial product and is not intended for use in applications that require extraordinary levels of quality and reliability, such as automotive, aviation/aerospace and life-support devices or systems.

Any and all semicondutor products have certain probability to fail or malfunction, which may result in personal injury, death or property damage. Customer are solely responsible for providing adequate safe measures when design their systems.

CRM(CQ) reserves the right to improve product design, function and reliability without notice.

